

Search Notes

Application/Control No.

10/722,393

Examiner

Jinhee J. Lee

Applicant(s)/Patent under
Reexamination

FLANIGAN, MICHAEL

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner
715	719	1/20/2007	LEE
352	Text	1/	1/

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
715	719	1/20/2007	LEE
352	text	1/	1/

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search	1/20/2007	LEE